IRF740A / RF1S740AST



## IRF740A / RF1S740AST

### 10A, 400V, 0.550 Ohm, N-Channel SMPS Power MOSFET

### **Applications**

- Switch Mode Power Supplies (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

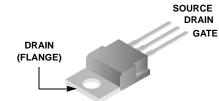
### **Features**

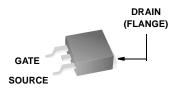
- Low Gate Charge  $\mathbf{Q}_{\mathbf{g}}$  results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dv/dt Ruggedness
- Improved Body Diode

# Package Symbol

JEDEC TO-220AB

**JEDEC TO-263AB** 







### Absolute Maximum Ratings T<sub>J</sub> = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain to Source Voltage	400	V
$V_{GS}$	Gate to Source Voltage	±30	V
	Drain Current		
	Continuous ( $T_C = 25^{\circ}C$ , $V_{GS} = 10V$ )	10	Α
ID	Continuous ( $T_C = 100^{\circ}$ C, $V_{GS} = 10V$ )	6.3	Α
	Pulsed	40	Α
$P_{D}$	Power dissipation	147	W
	Derate above 25°C	1.18	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55 to 150	°C
	Soldering Temperature for 10 seconds	300 (1.6mm from case)	°C
	Mounting Torque, 8-32 or M3 Screw	10ibf*in (1.1N*m)	

### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance Junction to Case	0.85	°C/W
$R_{\theta CS}$	Thermal Resistance Case to Sink, Flat, Greased Surface	0.50 TYP	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	62	°C/W

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Package	Marking	and	Ordering	Inf	formation
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Device Marking	Device	Package	Reel Size	Tape Width	Quantity
IRF740A	IRF740A	TO-220AB	Tube	NA	50
RF1S740A	RF1S740AST	TO-263AB	330mm	24mm	800

# **Electrical Characteristics** $T_J = 25^{\circ}C$ (unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Statics						
B <sub>VDSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	400	-	-	V
	Breakdown Voltage Temp. Coefficient	V/°C Reference to 25°C, ID = 1mA	-	0.48	-	
r <sub>DS(ON)</sub>	Drin to Source On-Resistance	$V_{GS} = 10V, I_D = 6A$	-	0.40	0.55	Ω
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0	3.6	4.0	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 350V$ $V_{GS} = 0V$ $T_{C} = 150^{\circ}$	-	-	1 250	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20V	-	-	±100	nA
Dynamics			•			
9 <sub>fs</sub>	Forward Transconductance	$V_{DS} = 50V, I_{D} = 6A$	4.9	-	-	S
Q <sub>g(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 10V,		17.2	22	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	V <sub>DS</sub> = 320V,	-	4.5	6.0	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	I <sub>D</sub> = 10A	-	5.8	7.5	nC
t <sub>d(ON)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 200V,	-	6	-	ns
t <sub>r</sub>	Rise Time	$I_D = 10A$	-	8	-	ns
t <sub>d(OFF)</sub>	Turn-Off Delay Time	$R_G = 10\Omega$	-	21	-	ns
t <sub>f</sub>	Fall Time	$R_D = 19.5\Omega$	-	7	-	ns
C <sub>ISS</sub>	Input Capacitance	V 25V V 20V	-	1060	-	pF
C <sub>OSS</sub>	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$ $V_{DS} = 1MHz$	-	150	-	pF
C <sub>RSS</sub>	Reverse Transfer Capacitance	1 - 11/11/2	-	7.8	-	pF
C <sub>OSS</sub>	Output Capacitance	$V_{GS} = 0V$ , $V_{DS} = 1V$ , f = 1MHz	-	1490	-	pF
C <sub>OSS</sub>	Output Capacitance	$V_{GS} = 0V, V_{DS} = 320V,$ f = 1MHz	-	52	-	pF
Avalanche	e Characteristics					
E <sub>AS</sub>	Single Pulse Avalanche Energy		630	-	-	mJ
I <sub>AR</sub>	Avalanche Current	7	-	-	10	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	7	12.5	-	-	mJ
Drain-Sou	rce Diode Characteristics					
I <sub>S</sub>	Continuous Source Current (Body Diode)	MOSFET symbol showing the	-	-	10	А
I <sub>SM</sub>	Pulsed Source Current (Body Diode)	integral reverse p-n junction diode.	-	-	40	Α
V <sub>SD</sub>	Source to Drain Diode Voltage	I <sub>SD</sub> = 18A s	-	-	1.25 1.0	V
t <sub>rr</sub>	Reverse Recovery Time	$I_{SD} = 10A$ , $dI_{SD}/dt = 100A/ms$	-	240	360	ns
Q <sub>RR</sub>	Reverse Recovered Charge	$I_{SD} = 10A$ , $dI_{SD}/dt = 100A/ms$	_	1.9	2.9	μС

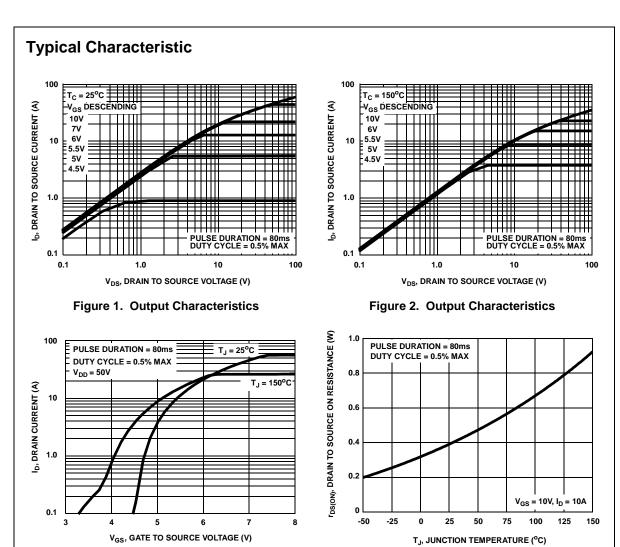


Figure 3. Transfer Characteristics

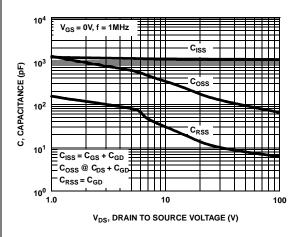


Figure 5. Capacitance vs Drain To Source Voltage

Figure 4. Drain To Source On Resistance vs Junction Temperatrue

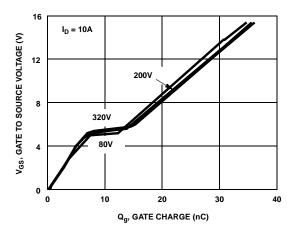
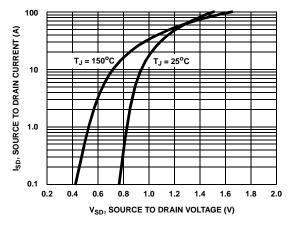


Figure 6. Gate Charge Waveforms For Constant Gate Current

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## **Typical Characteristic**



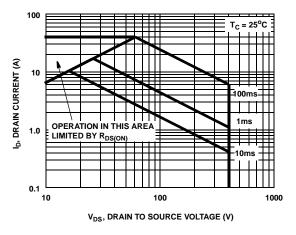


Figure 7. Source to Drain Diode Forward Voltage

Figure 8. Maximum Safe Operating Area

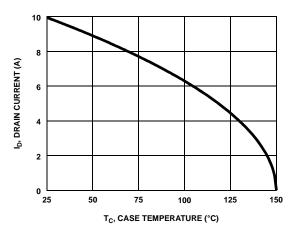


Figure 9. Maximum Drain Current vs Case Temperature

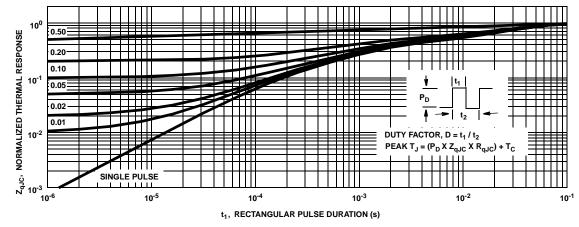


Figure 10. Normalized Transient Thermal Impedance, Junction to Case

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## **Test Circuits and Waveforms**

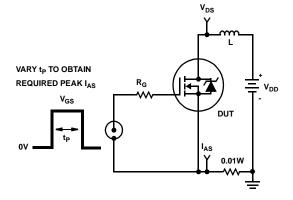


Figure 11. Unclamped Energy Test Circuit

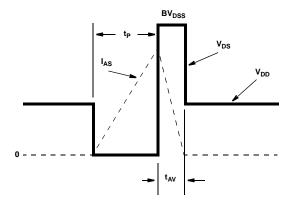


Figure 12. Unclamped Energy Waveforms

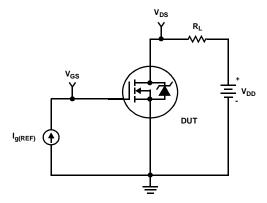


Figure 13. Gate Charge Test Circuit

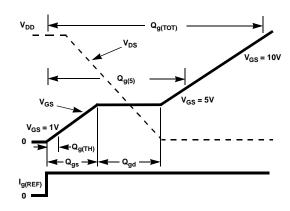


Figure 14. Gate Charge Waveforms

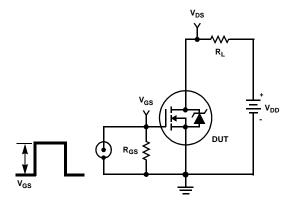


Figure 15. Switching Time Test Circuit

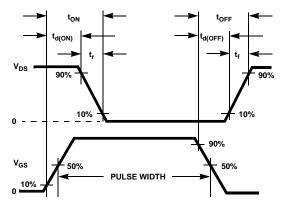


Figure 16. Switching Time Waveform

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